NOTES:

- SUBSTRATE **FUSED SILICA**
- 2. SURFACE S2 TO BE PARALLEL TO SURFACE S1 TO WITHIN <3 ARCMIN
- 3. COATING (APPLY ACROSS COATING APERTURE):

\$1: 355 HR Coating R (ABS) > 99.80% @ 355nm @ 45° AOI R(AVG) > 99.5% @ 351 - 358nm @ 45° AOI

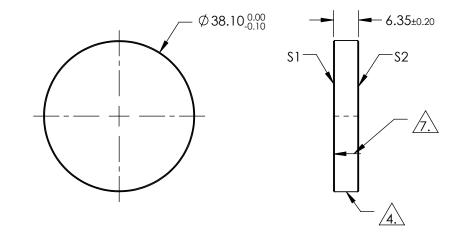
DAMAGE THRESHOLD, PULSED: 6 J/cm², 20ns, 20Hz @ 355nm CW: 1MW/cm² @ 355nm

S2: NONE

FINE GRIND SURFACE

- 5. POWER, IRREGULARITY, AND SURFACE QUALITY SPECIFICATIONS APPLY ACROSS CLEAR APERTURE
- 6. CLEAR APERTURE AND COATING APERTURE ARE CENTERED ON SURFACES

APPLY ARROW ON EDGE WITH LASER ETCH, PENCIL, OR PERMANENT INK POINTING TOWARDS SURFACE \$1



FOR INFORMATION ONLY: DO NOT MANUFACTURE PARTS TO THIS DRAWING

SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

	S1	S2				
SHAPE	PLANO	PLANO		P	Edmund Opt	icc®
SURFACE QUALITY	10-5	COMMERCIAL POLISH			Edillalla Opt	105
SURFACE FLATNESS	0.10 WAVE	N/A			Ø38.1mm x 6.35mm,355nm, NdYAG	MIRROR
MIN CLEAR APERTURE	Ø34.29	N/A	THIRD ANGLE PROJECTION	TITLE	45° AOI	MINKOK
MIN COATING APERTURE	Ø34.29	N/A	1		16 7 (8)	CHEET
BEVEL	PROTECTIVE AS NEEDED	PROTECTIVE AS NEEDED	ALL DIMS IN mm	DWG NO	34821	SHEET 1 OF 1